

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/707,584	<b>Applicant(s)/Patent under Reexamination</b> CHEN ET AL.
	<b>Examiner</b> Matthew G. Kayrish	<b>Art Unit</b> 2653

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	11/18/2005	MK
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	11/22/2005	MK
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	11/23/2005	MK
EAST (USPG-PUB, USPAT, USOCR) (See Attached Search History)	11/29/2005	MK
EAST (EPO, JPO, IBM_TDB, DERWENT) (See Attached Search History)	11/23/2005	MK

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
720	610	12/5/2005	MK
720	610	12/6/2005	MK
EAST (USPG-PUB)		12/6/2005	MK